

OPA1632 高性能、全差分音频运算放大器

1 特性

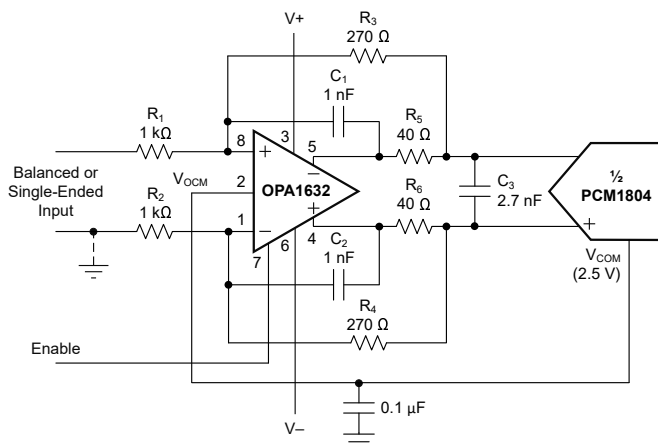
- 出色的音质
- 超低失真：0.000028%
- 低噪声：1.25nV/√Hz
- 高速：
 - 压摆率：72 V/μs
 - 增益带宽积：180 MHz
- 完全差分架构：
 - 平衡输入和输出将单端输入转换为平衡差分输出
- 宽电源电压范围：±2.5V 至 ±15V
- 关断电流：0.85mA ($V_S = \pm 5V$)
- 温度范围：-40°C 至 +85°C

2 应用

- 专业音频混合器或控制平面
- 专业麦克风和无线系统
- 专业扬声器系统
- 专业音频放大器
- 条形音箱
- 转盘
- 专业摄像机
- 吉他和乐器放大器
- 数据采集 (DAQ)

3 说明

OPA1632 是一款全差分放大器 (FDA)，旨在驱动高性能音频模数转换器 (ADC) 或用作 D 类放大器的前置驱动器。



应用示意图

OPA1632 可实现卓越的音频质量、极低的噪声、大输出电压摆幅和高电流驱动。OPA1632 具有 180MHz 的出色增益带宽以及 72V/μs 的超快转换率，有助于实现极低的失真。1.25nV/√Hz 的极低输入电压噪声可进一步提高信噪比和动态范围。

全差分架构的灵活性有助于轻松实现单端到全差分输出转换。差分输出可减少偶次谐波并最大限度地减少共模噪声干扰。OPA1632 在用于驱动高性能音频 ADC (如 PCM1804) 时可提供卓越的性能。添加了关断功能以在器件未使用时节省电量。

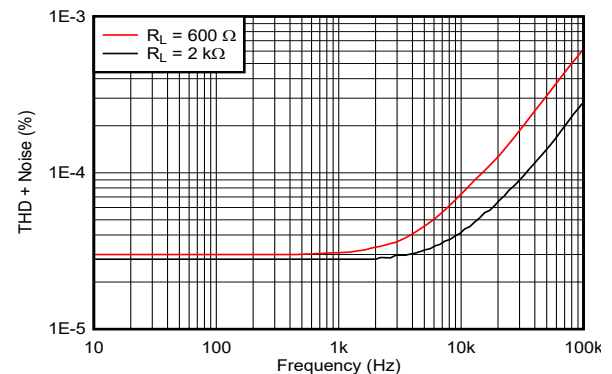
OPA1632 可在 -40°C 至 +85°C 的温度范围内正常运行，采用 SO-8 封装和热增强型 HVSSOP-8 PowerPAD™ 集成电路封装。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 ⁽²⁾
OPA1632	D (SOIC, 8)	4.9mm × 6mm
	DGN (HVSSOP, 8)	3mm × 4.9mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

(2) 封装尺寸 (长 × 宽) 为标称值，并包括引脚 (如适用)。



THD+N 与频率间的关系



Table of Contents

1 特性	1	7.4 Device Functional Modes.....	14
2 应用	1	8 Application and Implementation	15
3 说明	1	8.1 Application Information.....	15
4 Revision History	2	8.2 Typical Application.....	16
5 Pin Configuration and Functions	5	8.3 Power Supply Recommendations.....	17
6 Specifications	6	8.4 Layout.....	17
6.1 Absolute Maximum Ratings.....	6	9 Device and Documentation Support	21
6.2 ESD Ratings.....	6	9.1 Documentation Support.....	21
6.3 Recommended Operating Conditions.....	6	9.2 接收文档更新通知.....	21
6.4 Thermal Information.....	6	9.3 支持资源.....	21
6.5 Electrical Characteristics.....	8	9.4 Trademarks.....	21
6.6 Typical Characteristics.....	11	9.5 静电放电警告.....	21
7 Detailed Description	13	9.6 术语表.....	21
7.1 Overview.....	13	10 Mechanical, Packaging, and Orderable Information	21
7.2 Functional Block Diagram.....	13		
7.3 Feature Description.....	14		

4 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision D (March 2022) to Revision E (August 2023)	Page
• 将 MSOP 封装的所有实例更改为 VSSOP 封装，将 MSOP PowerPAD 的所有实例更改为 HVSSOP.....	1
• Changed ambient temperature in Recommended Operating Conditions to show only -40°C to +85°C.....	6
• Changed thermal specifications for DGN package in Thermal Information table.....	6
• Changed Electrical Characteristics (EC) to combine both tables in to one table for both packages.....	8
• Changed PSRR minimum limit of 316 $\mu\text{V/V}$ to maximum limit in EC table for DGN package.....	8
• Changed input offset drift, input voltage noise, small and large signal bandwidth, slew rate, rise and fall time, settling time, output voltage swing, and closed-loop output impedance to show improved values.....	8
• Changed typical and maximum input bias current from 2 μA to 7.9 μA and 6 μA to 14 μA , respectively for DGN package.....	8
• Changed input current noise from 0.4 pA/ $\sqrt{\text{Hz}}$ to 1.7 pA/ $\sqrt{\text{Hz}}$ in EC table for DGN package.....	8
• Changed input impedance spec to show both common-mode and differential impedances in EC table for DGN package.....	8
• Changed typical THD+N with differential input/output and $R_L = 2 \text{ k}\Omega$ from 0.000022% to 0.000028% in EC table for DGN package.....	8
• Changed IMD of differential input/output and $R_L = 2 \text{ k}\Omega$ from 0.00005% to 0.000061% in EC table for DGN package.....	8
• Changed voltage output swing low and high to a typical only for a load of 2 $\text{k}\Omega$ in the EC table for DGN package.....	8
• Changed the enable and disable voltage threshold from $(V-) + 2 \text{ V}$ and $(V-) 0.8 \text{ V}$ to $(V-) + 1.45 \text{ V}$ and $(V-) 1.4 \text{ V}$, respectively, for DGN package.....	8
• Changed one Turn-on delay specification to Turn-off delay in Electrical Characteristics table.....	8
• Deleted the DGN Typical Characteristics section and combined all plots into one section.....	11
Changes from Revision C (September 2015) to Revision D (March 2022)	Page
• 更新了整个文档中的表格、图和交叉参考的编号格式.....	1
• 更新了 特性 部分.....	1
• 更新了 应用 部分.....	1
• 更新了 说明 部分.....	1
• 更改了 说明 部分中 SOIC 和 MSOP-PowerPAD 封装的标称封装尺寸.....	1

• Updated <i>Pin Configuration and Functions</i> section.....	5
• Added Supply turn-on/off dV/dT specification to Absolute Maximum Ratings table.....	6
• Added continuous input current specification to Absolute Maximum Ratings table.....	6
• Changed differential input voltage in Absolute Maximum Ratings table from $\pm 3V$ to $\pm 1.5V$;	6
• Changed charged-device model (CDM) reference from JESD22-C101 to JS-002 in ESD Ratings	6
table.....	6
• Changed minimum temperature range from $0.4^{\circ}C$ to $-40^{\circ}C$ in Recommended Operating	6
Conditions table.....	6
• Changed thermal specifications for D package in Thermal Information table.....	6
• Changed $R_{\theta JA}$ from $114.5^{\circ}C/W$ to $126.3^{\circ}C/W$ for D Package in Thermal Information table.....	6
• Changed $R_{\theta JC(top)}$ from $60.3^{\circ}C/W$ to $67.3^{\circ}C/W$ for D package in Thermal Information table.....	6
• Changed $R_{\theta JB}$ from $54.8^{\circ}C/W$ to $69.8^{\circ}C/W$ for D package in Thermal Information table.....	6
• Changed ψ_{JT} from $14^{\circ}C/W$ to $19.5^{\circ}C/W$ for D package in Thermal Information table.....	6
• Changed ψ_{JT} from $54.3^{\circ}C/W$ to $69.0^{\circ}C/W$ for D package in Thermal Information table.....	6
• Changed typical offset voltage vs temperature from $\pm 5 \mu V/^{\circ}C$ to $\pm 2.5 \mu V/^{\circ}C$ in <i>Electrical Characteristics:</i>	8
<i>OPA1632D</i> table.....	8
• Changed PSRR minimum limit of $316 \mu V/V$ to maximum limit in <i>Electrical Characteristics: OPA1632D</i> ...	8
.....	8
• Changed typical input bias current limit from $2 \mu A$ to $7.9 \mu A$ in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed Max input bias current limit from $6 \mu A$ to $14 \mu A$ in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed typical input voltage noise from $1.3 nV/\sqrt{Hz}$ to $1.25 nV/\sqrt{Hz}$ in <i>Electrical Characteristics:</i>	8
<i>OPA1632D</i> table.....	8
• Changed typical input current noise from $0.4 pA/\sqrt{Hz}$ to $1.7 pA/\sqrt{Hz}$ in <i>Electrical Characteristics: OPA1632D</i>	8
table.....	8
• Changed input impedance spec to show both common-mode and differential impedances in <i>Electrical</i>	8
<i>Characteristics: OPA1632D</i> table.....	8
• Changed SSBW at $G = +2$, $R_F = 602 \Omega$ from $90 MHz$ to $104 MHz$ in <i>Electrical Characteristics: OPA1632D</i>	8
table.....	8
• Changed SSBW at $G = +5$, $R_F = 1.5 k\Omega$ from $36 MHz$ to $46 MHz$ in <i>Electrical Characteristics: OPA1632D</i>	8
table.....	8
• Changed SSBW at $G = +10$, $R_F = 3.01 k\Omega$ from $18 MHz$ to $24 MHz$ in <i>Electrical Characteristics: OPA1632D</i>	8
table.....	8
• Changed typical Large-Signal Bandwidth from $800 kHz$ to $1.8 MHz$ in <i>Electrical Characteristics: OPA1632D</i>	8
table.....	8
• Changed typical slew rate from $50 V/\mu s$ to $72 V/\mu s$ in <i>Electrical Characteristics: OPA1632D</i> table	8
• Changed typical rise/fall time from $100 ns$ to $69 ns$ in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed typical settling time to 0.1% from $75 ns$ to $36 ns$ in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed typical settling time to 0.01% from $200 ns$ to $49 ns$ in <i>Electrical Characteristics: OPA1632D</i> table	8
• Changed typical THD+N with Differential Input/Output and $R_L = 600 \Omega$ from 0.0003% to 0.00003% in	8
<i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed typical THD+N with Differential Input/Output and $R_L = 2 k\Omega$ from 0.000022% to 0.000028%	8
in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed typical THD+N with single-ended Input/Output and $R_L = 600 \Omega$ from 0.000059% to 0.000036%	8
in <i>Electrical Characteristics: OPA1632D</i> table	8
• Changed typical THD+N with single-ended Input/Output and $R_L = 2 k\Omega$ from 0.000043% to 0.000031% in	8
<i>Electrical Characteristics: OPA1632D</i> table.....	8
• Changed IMD at differential input/output and $R_L = 600 \Omega$ from 0.00008% to 0.000061% in <i>Electrical</i>	8
<i>Characteristics: OPA1632D</i> table.....	8
• Changed IMD at differential input/output and $R_L = 2 k\Omega$ from 0.00005% to 0.000061% in <i>Electrical</i>	8
<i>Characteristics: OPA1632D</i> table.....	8

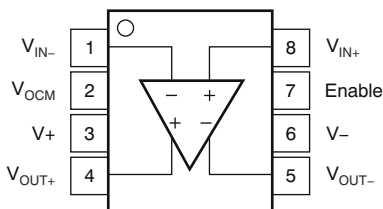
• Changed IMD at single-ended input/output and $R_L = 600\Omega$ from 0.0001% to 0.00007% in <i>Electrical Characteristics: OPA1632D</i> table	8
• Changed IMD at single-ended input/output and $R_L = 2k\Omega$ from 0.0007% to 0.000073% in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Removed specified operating voltage specifications from <i>Electrical Characteristics: OPA1632D</i> table	8
• Changed typical I_Q from 14mA to 13mA in <i>Electrical Characteristics: OPA1632D</i> table.....	8
• Added new Typical Characteristics section for D package.....	11
• Updated <i>Feature Description</i> section.....	14
• Updated <i>Output Common-Mode Voltage</i> section.....	15
• Updated <i>Resistor Matching</i> section.....	15
• Updated <i>Application Curves</i> section.....	17
• Updated <i>Power Supply Recommendations</i> section.....	17
• Updated the <i>Power Dissipation and Thermal Considerations</i> section.....	19
• Updated <i>Layout Example</i> section.....	20
• Changed list of documentation in <i>Related Documentation</i> section.....	21

Changes from Revision B (January 2010) to Revision C (September 2015)

Page

• 添加了 ESD 等级表、特性说明部分、器件功能模式、应用和实施部分、电源相关建议部分、布局部分、器件和文档支持部分以及机械、封装和可订购信息部分	1
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5 Pin Configuration and Functions



**图 5-1. D Package, 8-Pin SOIC or
DGN Package⁽¹⁾, 8-Pin HVSSOP
(Top View)**

表 5-1. Pin Functions

PIN		TYPE ⁽²⁾	DESCRIPTION
NAME	NO.		
Enable	7	I	Active high enable pin
V+	3	I/O	Positive supply voltage pin
V -	6	I/O	Negative supply voltage pin
V _{IN+}	8	I	Positive input voltage pin
V _{IN -}	1	I	Negative input voltage pin
V _{OCM}	2	I	Output common-mode control voltage pin
V _{OUT+}	4	O	Positive output voltage pin
V _{OUT -}	5	O	Negative output voltage pin

(1) Solder the exposed DGN (HVSSOP) package thermal pad to a heat-spreading power or ground plane. This pad is electrically isolated from the die, but must be connected to a power or ground plane and not floated.

(2) I = input, O = output.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)^{(1) (2)}

		MIN	MAX	UNIT
V_S	Supply voltage		±16.5	V
	Supply turn on and turn off dV/dT ⁽³⁾		1.7	V/μs
V_I	Input voltage		± V_S	V
I_O	Output current		150	mA
I_{IN}	Continuous input current		10	mA
V_{ID}	Differential input voltage		±1.5	V
T_J	Junction temperature		150	°C
T_A	Ambient temperature	– 40	85	°C
T_{stg}	Storage temperature	– 65	150	°C

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The OPA1632 HVSSOP PowerPAD integrated circuit package incorporates a thermal pad on the underside of the chip. This thermal pad acts as a heat sink and must be connected to a thermally-dissipative plane for proper power dissipation. Failure to do so can result in exceeding the maximum junction temperature, which can permanently damage the device. See TI technical brief [SLMA002](#) for more information about using the thermally-enhanced PowerPAD integrated circuit package.
- (3) Stay below this specification to make sure that the edge-triggered ESD absorption devices across the supply pins remain off.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1000	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±500	
		Machine model	±200	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_S	Supply voltage	Dual	±2.5	±15	V
		Single	5	30	
T_A	Ambient temperature		–40	85	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		OPA1632		UNIT
		D (SOIC)	DGN (HVSSOP)	
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	126.3	57.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	67.3	76.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	69.8	30.0	°C/W
ψ_{JT}	Junction-to-top characterization parameter	19.5	4.0	°C/W
ψ_{JB}	Junction-to-board characterization parameter	69.0	29.9	°C/W

THERMAL METRIC ⁽¹⁾		OPA1632		UNIT
		D (SOIC)	DGN (HVSSOP)	
		8 PINS	8 PINS	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	14.3	°C/W

(1) For information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

at $V_S = \pm 15\text{ V}$, $R_F = 390\ \Omega$, $R_L = 800\ \Omega$, and $G = +1$ (unless otherwise noted)

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
OFFSET VOLTAGE								
Input offset voltage						±0.5	±3	mV
	vs temperature, dc	dV _{OS} /dT				±2.5		μ V/°C
	vs power supply, dc	PSRR				13	316	μ V/V
INPUT BIAS CURRENT								
Input bias current, I _B						7.9	14	μ A
Input offset current, I _{OS}						±100	±500	nA
NOISE								
Input voltage noise			f = 10 kHz			1.25		nV/ √ Hz
Input current noise			f = 10 kHz			1.7		pA/ √ Hz
INPUT VOLTAGE								
Common-mode input voltage					(V ⁻) + 1.5		(V ⁺) - 1	V
Common-mode rejection ratio, dc					74	90		dB
INPUT IMPEDANCE								
Input impedance			Measured into each input pin, common-mode		215 1.4			M Ω pF
			Measured into each input pin, differential		10 3.1			k Ω pF
OPEN-LOOP GAIN								
Open-loop gain, dc					66	78		dB
FREQUENCY RESPONSE								
Small-signal bandwidth			G = +1, R _F = 348 Ω		180		MHz	
			V _O = 100 mV _{PP} , peaking < 0.5 dB	G = +2, R _F = 602 Ω	104			
				G = +5, R _F = 1.5 k Ω	46			
				G = +10, R _F = 3.01 k Ω	24			
Bandwidth for 0.1-dB flatness			G = +1, V _O = 100 mV _{PP}		40		MHz	
Peaking at a gain of 1			V _O = 100 mV _{PP}		0.5		dB	
Large-signal bandwidth			G = +2, V _O = 20 V _{PP}		1.8		MHz	
Slew rate (25% to 75%)			G = +1		72		V/ μ s	
Rise and fall time			G = +1, V _O = 5-V step		69		ns	
Settling time	To 0.1%		G = +1, V _O = 2-V step		36		ns	
	To 0.01%		G = +1, V _O = 2-V step		49			
Total harmonic distortion + noise		Differential input/output	G = +1, f = 1 kHz, V _O = 3 V _{RMS}	R _L = 600 Ω	0.00003%			
				R _L = 2 k Ω	0.000028%			
		Single-ended in/differential out	G = +1, f = 1 kHz, V _O = 3 V _{RMS}	R _L = 600 Ω	0.000036%			
				R _L = 2 k Ω	0.000031%			
Intermodulation distortion		Differential input/output	G = +1, SMPTE/DIN, V _O = 2 V _{PP}	R _L = 600 Ω	0.000061%			
				R _L = 2 k Ω	0.000061%			
		Single-ended in/differential out	G = +1, SMPTE/DIN, V _O = 2 V _{PP}	R _L = 600 Ω	0.000073%			
				R _L = 2 k Ω	0.00007%			

6.5 Electrical Characteristics (续)

at $V_S = \pm 15\text{ V}$, $R_F = 390\ \Omega$, $R_L = 800\ \Omega$, and $G = +1$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Headroom	THD < 0.01%, $R_L = 2\text{ k}\Omega$		20		V_{PP}

6.5 Electrical Characteristics (续)

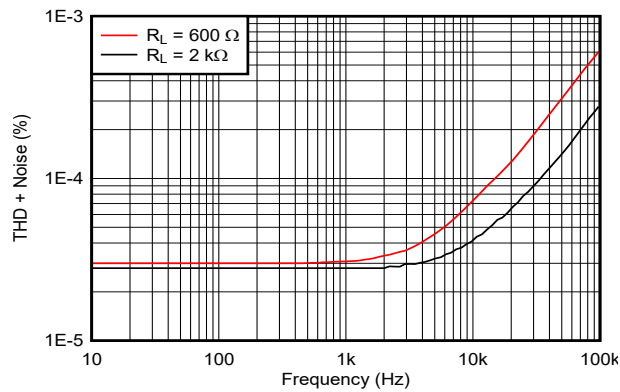
at $V_S = \pm 15\text{ V}$, $R_F = 390\ \Omega$, $R_L = 800\ \Omega$, and $G = +1$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OUTPUT						
Voltage output swing low	$R_L = 2\text{ k}\Omega$	$(V-) + 1.6$			V	
	$R_L = 1\text{ k}\Omega$	$(V-) + 3.5$				
Voltage output swing high	$R_L = 2\text{ k}\Omega$	$(V+) - 1.6$			V	
	$R_L = 1\text{ k}\Omega$	$(V+) - 3.5$				
Short-circuit current, I_{SC}	Sourcing	50	85		mA	
	Sinking	-60	-85			
Closed-loop output impedance	$G = +1$, $f = 100\text{ kHz}$	0.22			Ω	
POWER DOWN						
Enable voltage threshold		$(V-) + 1.45$			V	
Disable voltage threshold		$(V-) + 1.4$			V	
Shutdown current ⁽¹⁾	$V_S = \pm 5\text{ V}$, $V_{ENABLE} = -5\text{ V}$	0.85			mA	
	$V_{ENABLE} = -15\text{ V}$	1.7				
Turn-on delay	Time for I_Q to reach 50%	2			$\mu\text{ s}$	
Turn-off delay	Time for I_Q to reach 50%	2			$\mu\text{ s}$	
POWER SUPPLY						
Quiescent current, I_Q		13			17.1	mA

(1) Amplifier has internal 250-k Ω pullup resistor to V_+ pin. This pullup resistor enables the amplifier with no connection to shutdown pin.

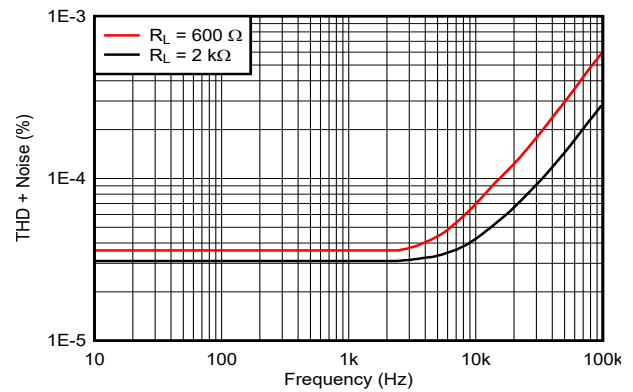
6.6 Typical Characteristics

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, $R_F = 348\ \Omega$, $G = +1$ and $R_L = 2\text{ k}\Omega$ (unless otherwise noted)



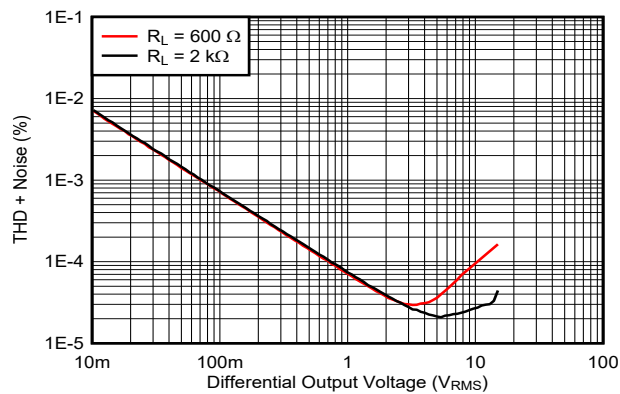
$V_O = 3\text{ V}_{\text{RMS}}$, differential input and output

图 6-1. THD + Noise vs Frequency



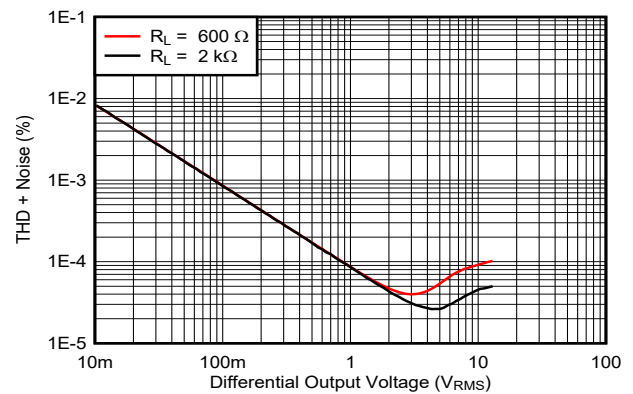
$V_O = 3\text{ V}_{\text{RMS}}$, single-ended input to differential output

图 6-2. THD + Noise vs Frequency



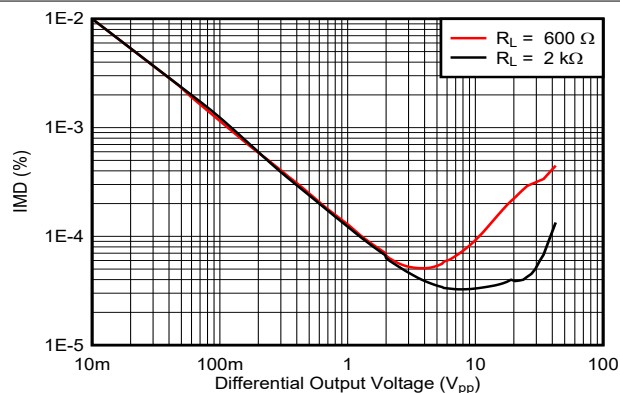
$f = 1\text{ kHz}$, differential input and output

图 6-3. THD + Noise vs Output Voltage



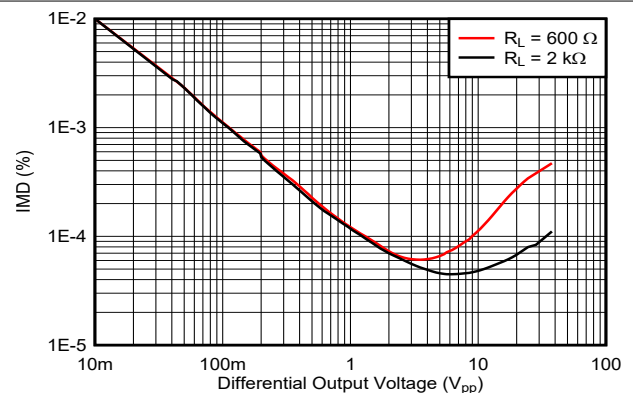
$f = 1\text{ kHz}$; single-ended input to differential output

图 6-4. THD + Noise vs Output Voltage



SMPTE 4:1: 60 Hz, 7 kHz; DIN 4:1: 250 Hz, 8 kHz, differential input and output

图 6-5. Intermodulation Distortion vs Output Voltage



SMPTE 4:1: 60 Hz, 7 kHz; DIN 4:1: 250 Hz, 8 kHz, differential input and output

图 6-6. Intermodulation Distortion vs Output Voltage

6.6 Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, $R_F = 348\ \Omega$, $G = +1$ and $R_L = 2\text{ k}\Omega$ (unless otherwise noted)

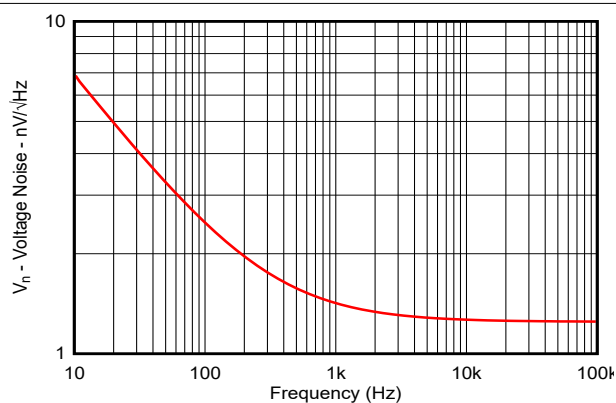


图 6-7. Voltage Noise vs Frequency

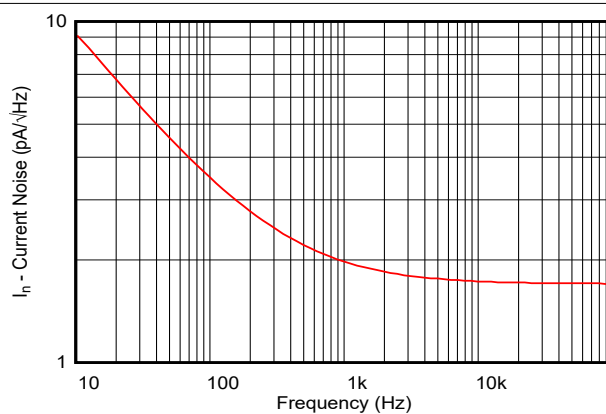


图 6-8. Current Noise vs Frequency

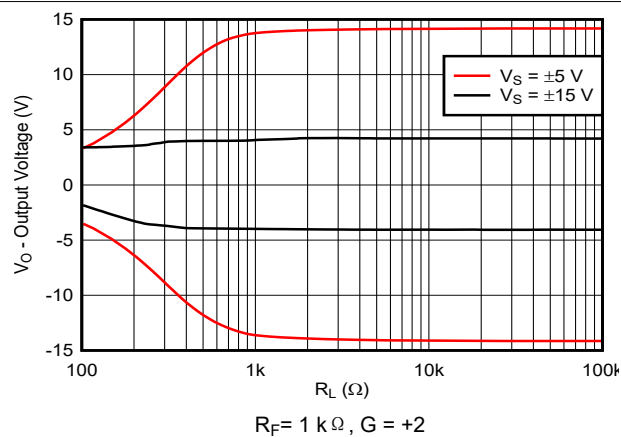


图 6-9. Output Voltage vs Differential Load Resistance

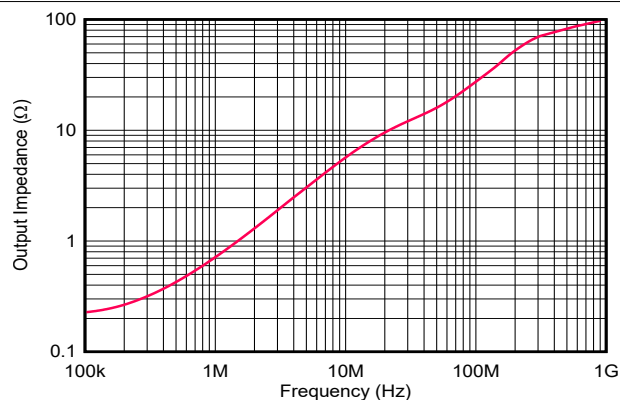


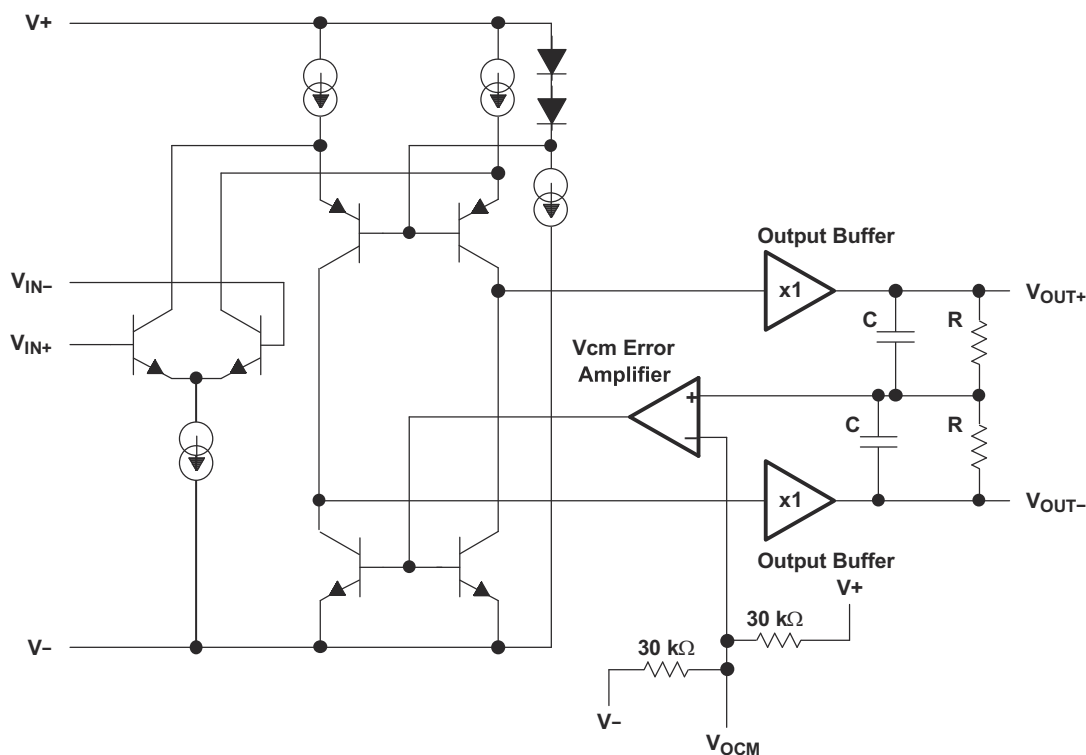
图 6-10. Output Impedance vs Frequency

7 Detailed Description

7.1 Overview

The OPA1632 is a fully differential amplifier (FDA). Differential signal processing offers a number of performance advantages in high-speed analog signal processing systems, including immunity to external common-mode noise, suppression of even-order nonlinearities, and increased dynamic range. FDAs not only serve as the primary means of providing gain to a differential signal chain, but also provide a monolithic solution for converting single-ended signals into differential signals allowing for easy, high-performance processing. For more information on the basic theory of operation for FDAs, refer to the [Fully Differential Amplifiers application note](#)

7.2 Functional Block Diagram



7.3 Feature Description

图 7-1 和 图 7-2 depict the differences between the operation of the OPA1632 in two different modes. FDAs can work with differential inputs or can be implemented as single input and differential output.

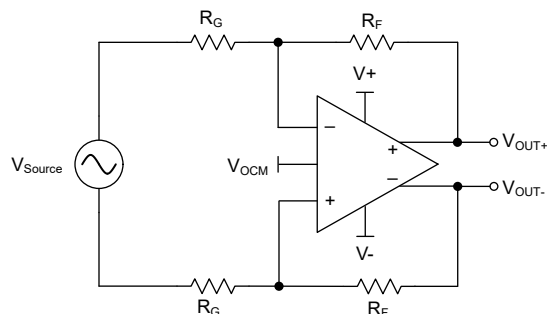


图 7-1. Amplifying Differential Input Signals

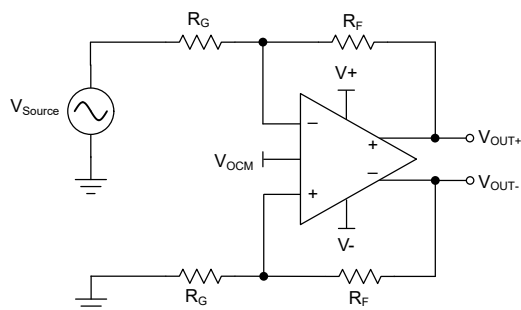


图 7-2. Amplifying Single-Ended Input Signals

7.4 Device Functional Modes

7.4.1 Shutdown Function

The shutdown (enable) function of the OPA1632 is referenced to the negative supply of the operational amplifier. A valid logic low ($< 0.8\text{ V}$ above negative supply) applied to the enable pin (pin 7) disables the amplifier output. Voltages applied to pin 7 that are greater than 2 V above the negative supply place the amplifier output in an active state, and the device is enabled. If pin 7 is left disconnected, an internal pull-up resistor enables the device. Turn-on and turn-off times are approximately $2\text{ }\mu\text{s}$ each.

Quiescent current is reduced to approximately 0.85 mA when the amplifier is disabled. When disabled, the output stage is *not* in a high-impedance state. Thus, the shutdown function cannot be used to create a multiplexed switching function in series with multiple amplifiers.

8 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

8.1 Application Information

8.1.1 Output Common-Mode Voltage

The output common-mode voltage pin sets the dc output voltage of the OPA1632. A voltage applied to the V_{OCM} pin from a low-impedance source can be used to directly set the output common-mode voltage. If left floating, the V_{OCM} pin defaults to the mid-rail voltage, defined as:

$$\frac{(V_+) + (V_-)}{2} \quad (1)$$

To minimize common-mode noise, connect a 0.1-uF bypass capacitor to the V_{OCM} pin. Output common-mode voltage causes additional current to flow in the feedback resistor network. This current is supplied by the output stage of the amplifier; therefore, additional power dissipation is created. For commonly-used feedback resistance values, this current is easily supplied by the amplifier. The additional internal power dissipation created by this current can be significant in some applications and can dictate use of the HVSSOP PowerPAD™ integrated circuit package to effectively control self-heating.

8.1.1.1 Resistor Matching

Resistor matching is important in FDAs to maintain good output balance. An ideal differential output signal implies the two outputs of the FDA should be exactly equal in amplitude and shifted 180° in phase. Any imbalance in amplitude or phase between the two output signals results in an undesirable common-mode signal at the output. The output balance error is a measure of how well the outputs are balanced and is defined as the ratio of the output common-mode voltage to the output differential signal.

$$\text{Output Balance Error} = \frac{\left(\frac{V_{OUT+} - V_{OUT-}}{2} \right)}{V_{OUT+} - V_{OUT-}} \quad (2)$$

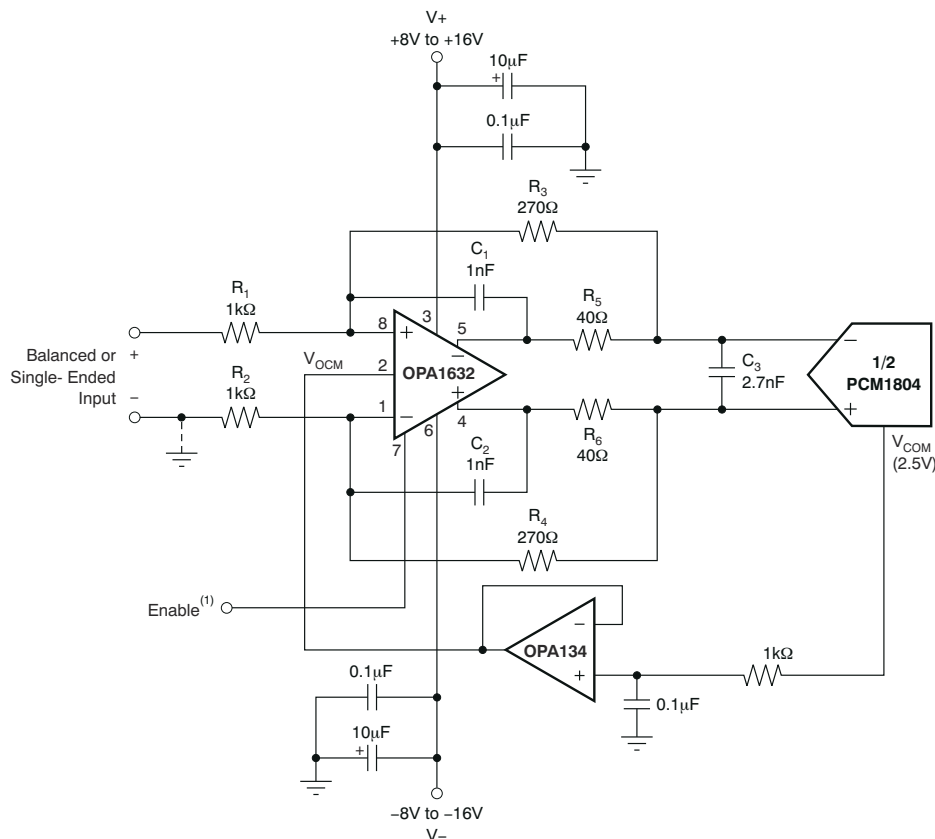
At low frequencies, resistor mismatch is the primary contributor to output balance errors. Additionally CMRR, PSRR, and HD2 performance diminish if resistor mismatch occurs. Therefore, use 1% tolerance resistors or better to optimize performance. See [表 8-1](#) for recommended resistor values to use for a particular gain.

表 8-1. Recommended Resistor Values

GAIN (V/V)	R_G (Ω)	R_F (Ω)
1	390	390
2	374	750
5	402	2010
10	402	4020

8.2 Typical Application

Figure 8-1 shows the OPA1632 used as a differential-output driver for the PCM1804 high-performance audio ADC.



🔗 8-1. ADC Driver for Professional Audio

8.2.1 Design Requirements

表 8-2 shows example design parameters and values for the typical application design example in 图 7-1.

表 8-2. Design Parameters

DESIGN PARAMETERS	VALUE
Supply voltage	$\pm 2.5\text{ V}$ to $\pm 15\text{ V}$
Amplifier topology	Voltage feedback
Output control	DC-coupled with output common-mode control capability
Filter requirement	500-kHz, multiple-feedback low-pass filter

8.2.2 Detailed Design Procedure

Supply voltages of ± 15 V are commonly used for the OPA1632. The relatively low input voltage swing required by the ADC allows use of lower power-supply voltage, if desired. Power supplies as low as ± 8 V can be used in this application with excellent performance. Lower-voltage operation reduces power dissipation and heat rise. Bypass power supplies with 10- μ F tantalum capacitors in parallel with 0.1- μ F ceramic capacitors to avoid possible oscillations and instability.

The V_{COM} reference voltage output on the PCM1804 ADC provides the proper input common-mode reference voltage (2.5 V). This V_{COM} voltage is buffered with op amp A_2 and drives the output common-mode voltage pin of the OPA1632. This biases the average output voltage of the OPA1632 to 2.5 V.

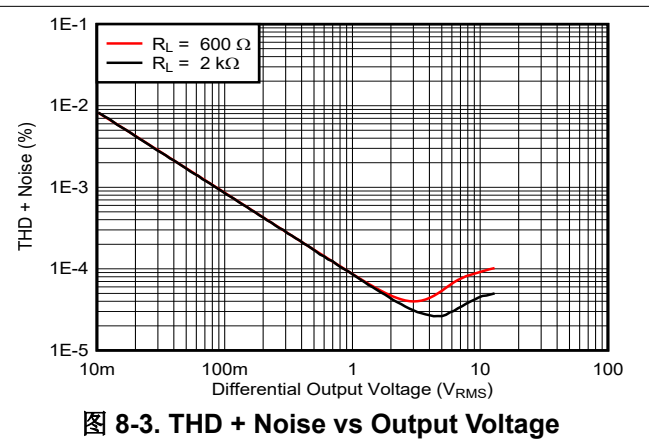
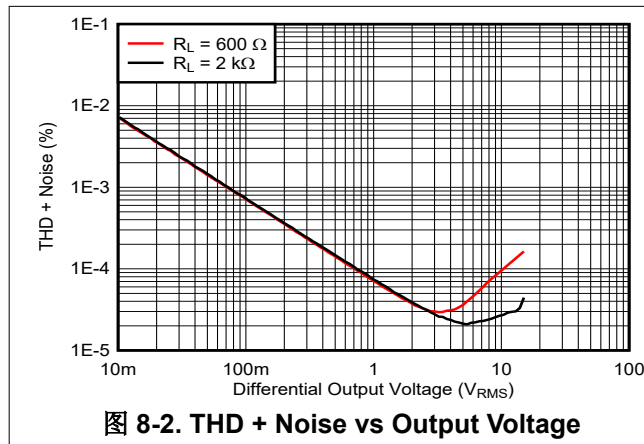
The signal gain of the circuit is generally set to approximately 0.25 to be compatible with commonly-used audio line levels. Gain can be adjusted, if necessary, by changing the values of R_1 and R_2 . Keep the feedback resistor values (R_3 and R_4) relatively low, as indicated, for best noise performance.

Resistors R_5 and R_6 and capacitor C_3 provide an input filter and charge glitch reservoir for the ADC. The values shown are generally satisfactory. Some adjustment of the values can help optimize performance with different ADCs.

Make sure to maintain accurate resistor matching on R_1/R_2 and R_3/R_4 to achieve good differential signal balance. Use 1% resistors for highest performance. When connected for single-ended inputs (inverting input grounded, as shown in 图 8-1), the source impedance must be low. Differential input sources must have well-balanced or low source impedance.

Choose capacitors C_1 , C_2 , and C_3 carefully for good distortion performance. Polystyrene, polypropylene, NPO ceramic, and mica types are generally excellent. Polyester and high-K ceramic types such as Z5U can create distortion.

8.2.3 Application Curves



8.3 Power Supply Recommendations

The OPA1632 device is designed to operate on power supplies ranging from ± 2.5 V to ± 15 V. Single power supplies ranging from 5 V to 30 V can also be used. Use a power-supply accuracy of 5%, or better. When operated on a board with high-speed digital signals, make sure to provide isolation between digital signal noise and the analog input pins. The OPA1632 is connected to power supplies through pin 3 (V_+) and pin 6 (V_-). Decouple each supply pin to GND as close to the device as possible with a low-inductance, surface-mount ceramic capacitor of approximately 10 nF. When vias are used to connect the bypass capacitors to a ground plane configure the vias for minimal parasitic inductance. One method of reducing via inductance is to use multiple vias. For broadband systems, two capacitors per supply pin are advised.

To avoid undesirable signal transients, do not power on the OPA1632 device with large inputs signals present. Careful planning of system power on sequencing is especially important to avoid damage to ADC inputs when an ADC is used in the application.

8.4 Layout

8.4.1 Layout Guidelines

1. The thermal pad is electrically isolated from the silicon and all leads. Connecting the thermal pad to any potential voltage between the power-supply voltages is acceptable, but best practice is to tie to ground because ground is generally the largest conductive plane.
2. Prepare the PCB with a top-side etch pattern as shown in 图 8-4. Use etch for the leads as well as etch for the thermal pad.

3. Place five holes in the area of the thermal pad that are 13 mils (0,03302 cm) in diameter. Keep these holes small so that solder wicking through the holes is not a problem during reflow.
4. Additional vias can be placed anywhere along the thermal plane outside of the thermal pad area. These vias help dissipate the heat generated by the OPA1632 device, and can be larger than the 13-mil diameter vias directly under the thermal pad. These vias can be larger because the vias are not in the thermal pad area to be soldered so that wicking is not a problem.
5. Connect all holes to the internal ground plane.
6. When connecting these holes to the plane, do not use the typical web or spoke via connection methodology. Web connections have a high thermal resistance connection that is useful for slowing the heat transfer during soldering operations. This slow heat transfer makes the soldering of vias that have plane connections easier. In this application, however, low thermal resistance is desired for the most efficient heat transfer. Therefore, make sure the holes under the OPA1632 PowerPAD™ integrated circuit package connect to the internal plane with a complete connection around the entire circumference of the plated through-hole.
7. The top-side solder mask must leave the package pins and the thermal pad area with the five holes exposed. The bottom-side solder mask must cover the five holes of the thermal pad area. This configuration prevents solder from being pulled away from the thermal pad area during the reflow process.
8. Apply solder paste to the exposed thermal pad area and all of the device pins.

With these preparatory steps in place, the device is simply placed in position and runs through the solder reflow operation as any standard surface-mount component. This process results in a part that is properly installed.

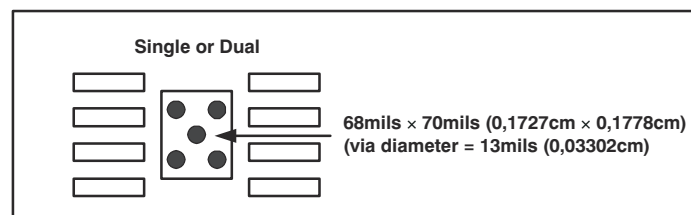


图 8-4. Thermal Pad PCB Etch and Via Pattern

8.4.1.1 PowerPAD™ Integrated Circuit Package Design Considerations

The OPA1632 is available in a thermally-enhanced PowerPAD™ integrated circuit package. This package is constructed using a downset leadframe upon which the die is mounted (see 图 8-5(a) and 图 8-5(b)). This arrangement results in the lead frame being exposed as a thermal pad on the underside of the package (see 图 8-5(c)). Because this thermal pad has direct thermal contact with the die, excellent thermal performance can be achieved by providing a good thermal path away from the thermal pad.

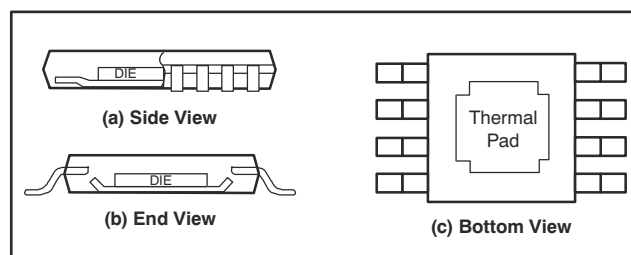


图 8-5. Views of the Thermally-Enhanced Package

The PowerPAD integrated circuit package allows for both assembly and thermal management in one manufacturing operation. During the surface-mount solder operation (when the leads are being soldered), the thermal pad must be soldered to a copper area underneath the package. Through the use of thermal paths within this copper area, heat can be conducted away from the package into either a ground plane or other heat-dissipating device. Soldering the thermal pad to the printed circuit board (PCB) is always required, even with

applications that have low power dissipation. The thermal pad provides the necessary thermal and mechanical connection between the lead frame die pad and the PCB.

8.4.1.2 Power Dissipation and Thermal Considerations

The OPA1632 does not have thermal shutdown protection. Make sure that the maximum junction temperature is not exceeded. Excessive junction temperature can degrade performance or cause permanent damage. For best performance and reliability, make sure that the junction temperature does not exceed the absolute maximum ratings for the junction temperature.

The thermal characteristics of the device are dictated by the package and the circuit board. Maximum power dissipation for a given package can be calculated using the following formula:

$$P_{DMax} = \frac{T_{Max} - T_A}{\theta_{JA}}$$

where:

- P_{DMax} is the maximum power dissipation in the amplifier (W)
- T_{Max} is the absolute maximum junction temperature ($^{\circ}C$)
- T_A is the ambient temperature ($^{\circ}C$)
- $\theta_{JA} = \theta_{JC} + \theta_{CA}$
- θ_{JC} is the thermal coefficient from the silicon junctions to the case ($^{\circ}C/W$)
- θ_{CA} is the thermal coefficient from the case to ambient air ($^{\circ}C/W$)

For systems where heat dissipation is more critical, the OPA1632 is offered in an HVSSOP-8 (DGN) PowerPAD integrated circuit package. The thermal coefficient for the PowerPAD integrated circuit package is substantially improved over the traditional SO package. Maximum power dissipation levels are depicted in 图 8-6 for the two packages. The data for the DGN package assume a board layout that follows the layout guidelines listed in 节 8.4.1.1.

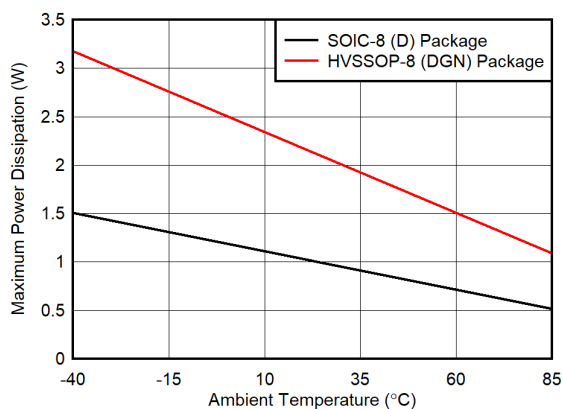


图 8-6. Maximum Power Dissipation vs Ambient Temperature

8.4.2 Layout Example

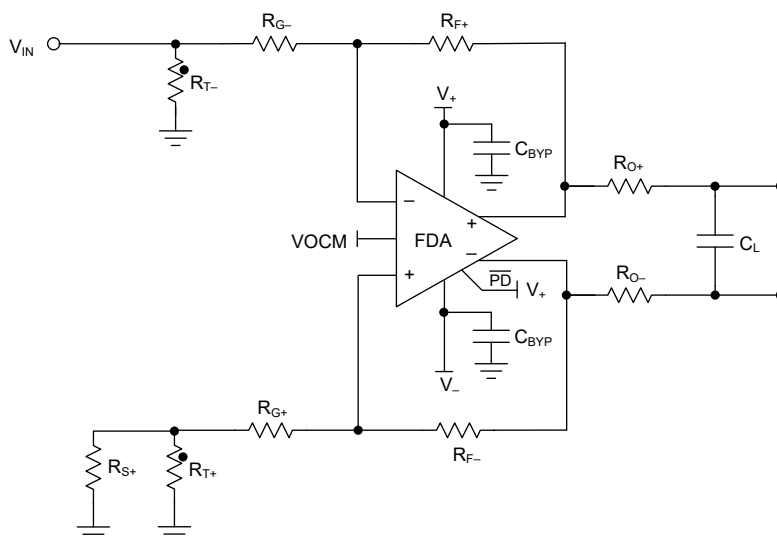


图 8-7. Representative Schematic for Example Layout

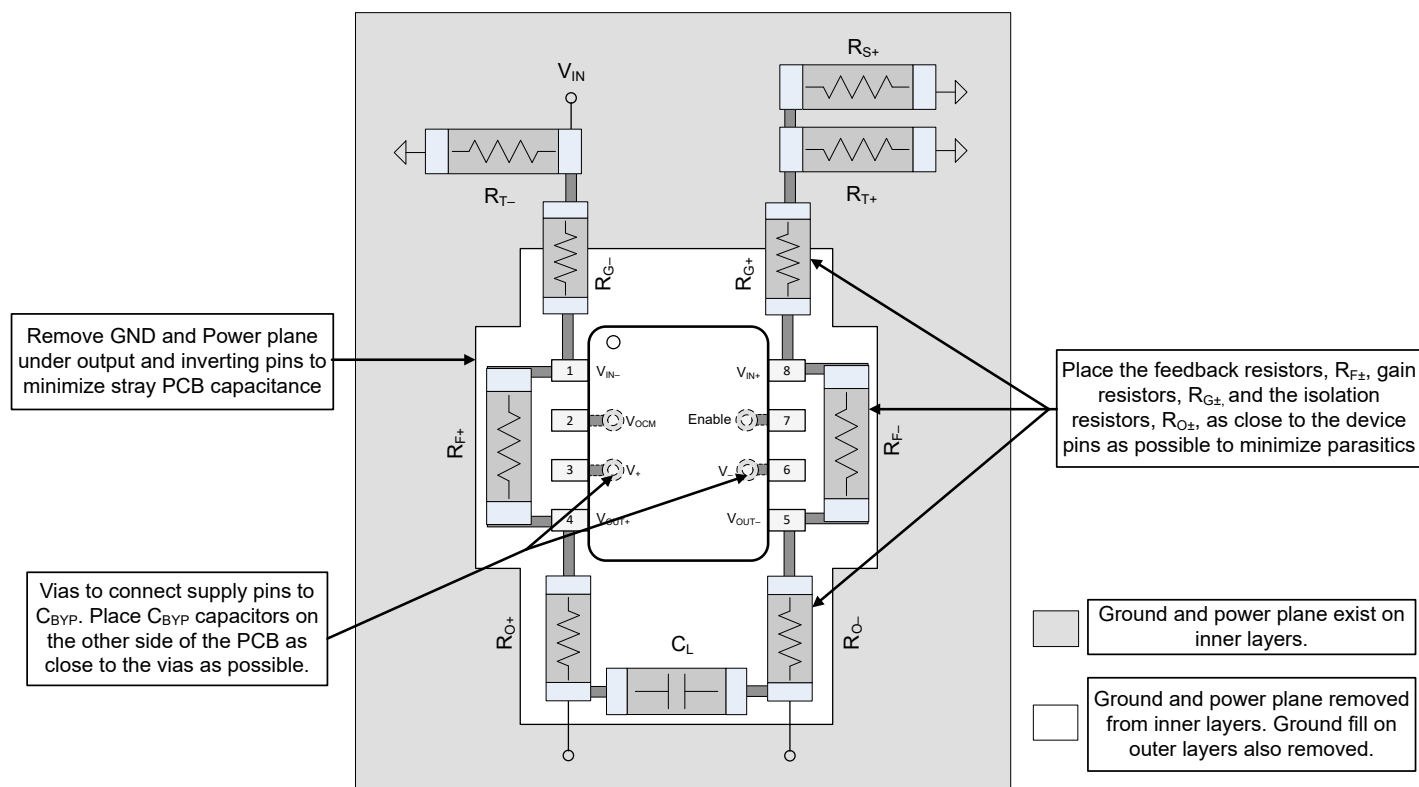


图 8-8. Example Layout

9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Fully Differential Amplifiers application note](#)
- Texas Instruments, [TI Precision Labs - Fully Differential Amplifiers video series](#)
- Texas Instruments, [Maximizing Signal-Chain Distortion Performance Using High-Speed Amplifiers application note](#)
- Texas Instruments, [Analog Audio Amplifier Front-End Reference Design With Improved Noise and Distortion](#)
- Texas Instruments, [Public Announcement Audio Reference Design Utilizing Best in Class Boost Controller](#)
- Texas Instruments, [Motherboard/Controller for the AMC1210 reference design](#)
- Texas Instruments, [TPA6120A2 Stereo, 9.0-V to 33.0-V, Analog Input Headphone Amplifier With 128-dB Dynamic Range](#)
- Texas Instruments, [OPAx863 Low-Power, 110-MHz, Rail-to-Rail Input/Output Voltage-Feedback Op Amps](#)
- Texas Instruments, [OPA2834 50-MHz, 170- \$\mu\$ A, Negative-Rail In, Rail-to-Rail Out, Voltage-Feedback Amplifier](#)

9.2 接收文档更新通知

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9.3 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

9.6 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
OPA1632D	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-40 to 85	OPA 1632
OPA1632DGN	Obsolete	Production	HVSSOP (DGN) 8	-	-	Call TI	Call TI	-40 to 85	1632
OPA1632DGNR	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1632
OPA1632DGNR.B	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1632
OPA1632DR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1632
OPA1632DR.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1632
OPA1632DRG4	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1632
OPA1632DRG4.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1632
OPA1632DRG4.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1632

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA1632DGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA1632DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA1632DRG4	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA1632DGNR	HVSSOP	DGN	8	2500	353.0	353.0	32.0
OPA1632DR	SOIC	D	8	2500	353.0	353.0	32.0
OPA1632DRG4	SOIC	D	8	2500	353.0	353.0	32.0

GENERIC PACKAGE VIEW

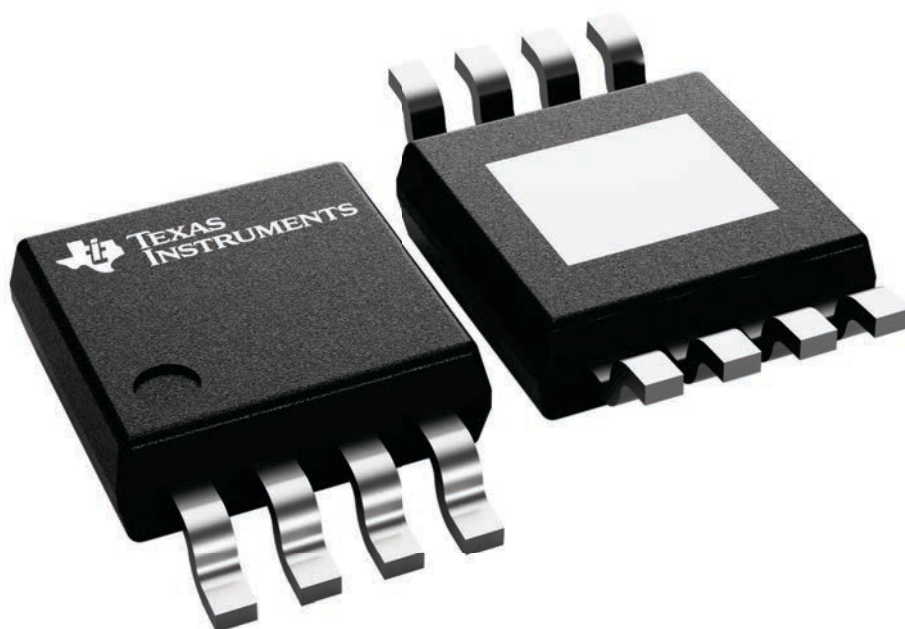
DGN 8

PowerPAD™ HVSSOP - 1.1 mm max height

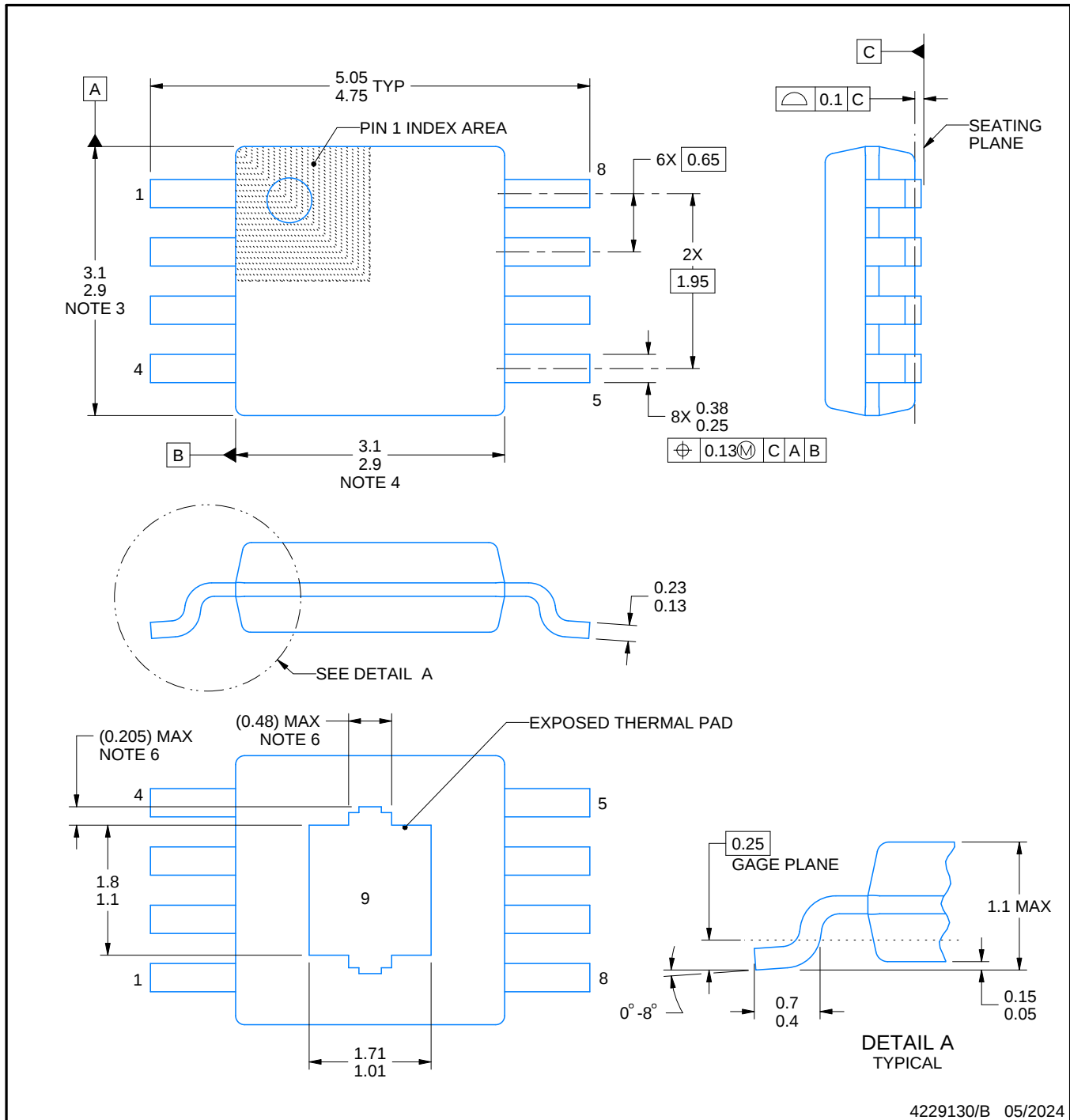
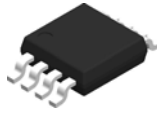
3 x 3, 0.65 mm pitch

SMALL OUTLINE PACKAGE

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4225482/B



4229130/B 05/2024

NOTES:

PowerPAD is a trademark of Texas Instruments.

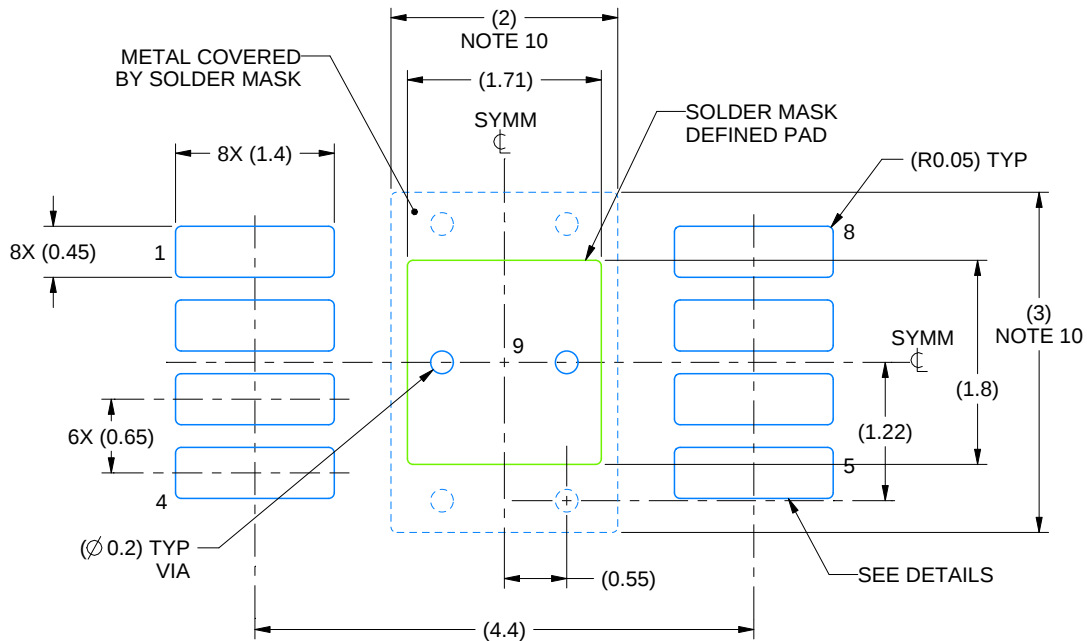
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.
6. Features may differ or may not be present.

EXAMPLE BOARD LAYOUT

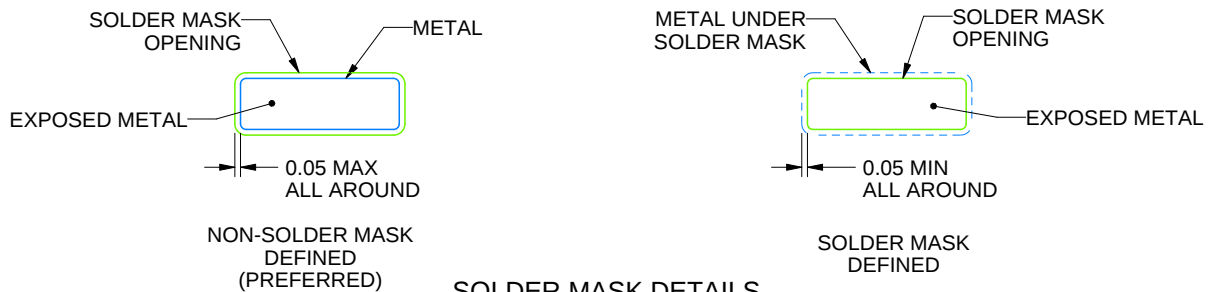
DGN0008H

PowerPAD™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



SOLDER MASK DETAILS

4229130/B 05/2024

NOTES: (continued)

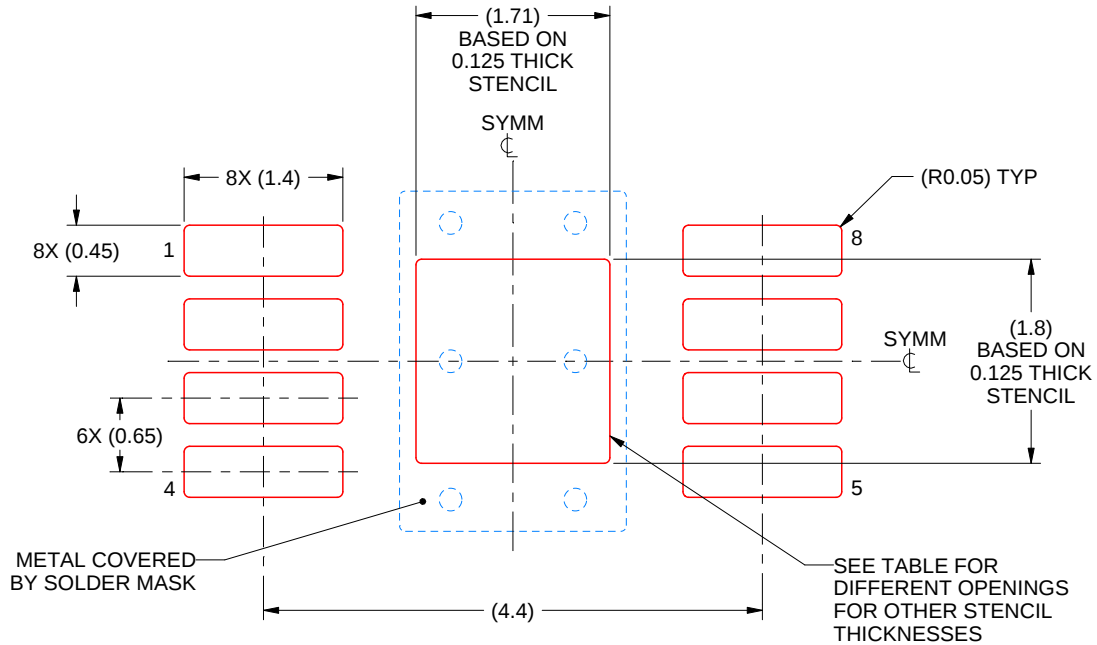
7. Publication IPC-7351 may have alternate designs.
8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
9. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
10. Size of metal pad may vary due to creepage requirement.

EXAMPLE STENCIL DESIGN

DGN0008H

PowerPAD™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
EXPOSED PAD 9:
100% PRINTED SOLDER COVERAGE BY AREA
SCALE: 15X

STENCIL THICKNESS	SOLDER STENCIL OPENING
0.1	1.91 X 2.01
0.125	1.71 X 1.80 (SHOWN)
0.15	1.56 X 1.64
0.175	1.45 X 1.52

4229130/B 05/2024

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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